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	v)	Art Unit	Unknown				
			,	Examiner Name Unknown			
Sheet	1	of	1	Attorney Docket Number	Q93964		

		U.S.	PATENT DOCUMI	ENTS
	Document Number			
Cite No.1	Number	Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Docume
	US			

			F	OREIGN PA	TENT DOCUMEN	TS	
Examiner Cite	Foreign Patent Document			Publication Date	Name of Patentee or		
Initials*	No.1	Country Code ³	Number ⁴	Kind Code ⁵ (if known)	MM-DD-YYYY	Applicant of Cited Document	Translation
		JP	10-273505	A	10-13-1998		
		JP	64-13139	A	01-18-1989		
		JР	7-92313	A	04-07-1995		
		JP	9-178901	A	07-11-1997		
		 					

		NON PATENT LITERATURE DOCUMENTS	
Examiner Initials*	Cite No.1	Include name of the author (in CAPITAL LETTERS), (title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city, and/or country where published.	Translation
		MASAYOSHI TANAKA, et al., "Samarium Enolate on Crosslinked Polystyrene Beads. II. An Anionic Initiator for the Well-Defined Synthesis of Pol(allyl methacrylate) on a Solid Support", Journal of Polymer Science Part A: Polymer Chemistry, March 15, 2003, pp. 858-860, Vol. 41, No. 6	
		M.J. BOWDEN, et al., "Mechanism of the Photoinduced Refractive Index Increase in Polymethyl Metacrylate", Applied Optics, January 1974, pp. 112-117, Vol. 13, No. 1	
		W. J. TOMLINSON, et al., "Photoinduced Regractive Index Increase in Poly(methImethacrylate) and its Applications", Applied Physics Letters, June 15, 1970, pp. 486-489, Vol. 16, No. 12	

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	rence considered, whether or not eitation is in conform	nance with MPEP 609. Draw line through eitation if n	ot in conformance and not considered. Include copy of

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